Search Notes

Application/Control No.	Applicant Reexamir
10/71/ 015	

10/711,845 Examiner

Thien F. Tran

Applicant(s)/Patent under Reexamination				

BREITWISCH ET AL.
Art Unit

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SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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